

Search Notes

Application/Control No.

10/816,096

Examiner

Richard K. Lee

Applicant(s)/Patent under
Reexamination

WENNER, JUSTIN B.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
200	61.04	6/13/2005	KL
	61.08		
	52R		
600	343		
	350		
	380		
SEARCH	updated	10/15/05	KL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR